

## SWITCHING REGULATOR APPLICATIONS

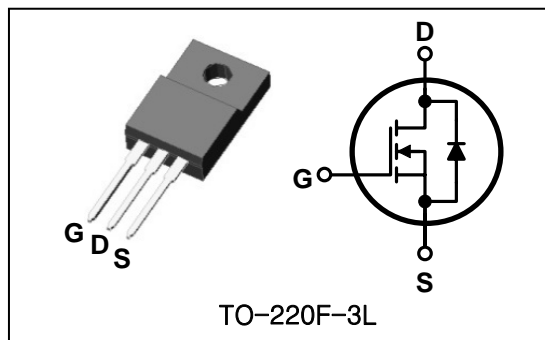
### Features

- High Voltage :  $V_{DSS}=250V(\text{Min.})$
- Low  $C_{RSS}$  :  $C_{RSS}=49pF(\text{Typ.})$
- Low gate charge :  $Qg=22nC(\text{Typ.})$
- Low  $R_{DS(on)}$  :  $R_{DS(on)}=0.27\Omega(\text{Max.})$

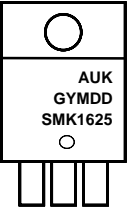
### Ordering Information

Type No.	Marking	Package Code
SMK1625F	SMK1625	TO-220F-3L

### PIN Connection



### Marking Diagram

	Column 1 : Manufacturer
	Column 2 : Production Information e.g.) GYMDD
	- . G : Factory management code - . YMDD : Date Code (year, month, date)
	Column 3 : Device Code

### Absolute maximum ratings ( $T_C=25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Rating	Unit	
Drain-source voltage	$V_{DSS}$	250	V	
Gate-source voltage	$V_{GSS}$	$\pm 30$	V	
Drain current (DC) *	$I_D$	$T_C=25^\circ\text{C}$	16	A
		$T_C=100^\circ\text{C}$	7.2	A
Drain current (Pulsed) *	$I_{DM}$	64	A	
Power dissipation	$P_D$	35	W	
Avalanche current (Single) ②	$I_{AS}$	16	A	
Single pulsed avalanche energy ②	$E_{AS}$	480	mJ	
Avalanche current (Repetitive) ①	$I_{AR}$	16	A	
Repetitive avalanche energy ①	$E_{AR}$	13.9	mJ	
Junction temperature	$T_J$	150	$^\circ\text{C}$	
Storage temperature range	$T_{stg}$	-55~150		

\* Limited by maximum junction temperature

Characteristic	Symbol	Typ.	Max.	Unit
Thermal resistance	Junction-case	-	3.57	$^\circ\text{C}/\text{W}$
	Junction-ambient	-	62.5	

## Electrical Characteristics (T<sub>C</sub>=25°C unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit	
Drain-source breakdown voltage	BV <sub>DSS</sub>	I <sub>D</sub> =250μA, V <sub>GS</sub> =0V	250	-	-	V	
Gate threshold voltage	V <sub>GS(th)</sub>	I <sub>D</sub> =250μA, V <sub>DS</sub> =V <sub>GS</sub>	2.0	-	4.0	V	
Drain-source cut-off current	I <sub>DSS</sub>	V <sub>DS</sub> =250V, V <sub>GS</sub> =0V	-	-	1	μA	
Gate leakage current	I <sub>GSS</sub>	V <sub>DS</sub> =0V, V <sub>GS</sub> =±30V	-	-	±100	nA	
Drain-source on-resistance ④	R <sub>DS(on)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =8.0A	-	0.22	0.27	Ω	
Forward transfer conductance ④	g <sub>fs</sub>	V <sub>DS</sub> =10V, I <sub>D</sub> =8.0A	-	10.5	-	S	
Input capacitance	C <sub>iss</sub>	V <sub>GS</sub> =0V, V <sub>DS</sub> =25V f=1 MHz	-	968	1275	pF	
Output capacitance	C <sub>oss</sub>		-	204	278		
Reverse transfer capacitance	C <sub>rss</sub>		-	49	64		
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DD</sub> =125V, I <sub>D</sub> =16A R <sub>G</sub> =25Ω	-	15	-	ns	
Rise time	t <sub>r</sub>		-	130	-		
Turn-off delay time	t <sub>d(off)</sub>		③④	-	135		-
Fall time	t <sub>f</sub>		-	105	-		
Total gate charge	Q <sub>g</sub>	V <sub>DS</sub> =200V, V <sub>GS</sub> =10V I <sub>D</sub> =16A	-	22	28	nC	
Gate-source charge	Q <sub>gs</sub>		③④	-	7.1		-
Gate-drain charge	Q <sub>gd</sub>		-	-	5.9		-

## Source-Drain Diode Ratings and Characteristics (T<sub>C</sub>=25°C unless otherwise noted)

Characteristic	Symbol	Test Condition	Min.	Typ.	Max.	Unit
Source current (DC)	I <sub>S</sub>	Integral reverse diode in the MOSFET	-	-	16	A
Source current (Pulsed) ①	I <sub>SM</sub>		-	-	64	
Forward voltage ④	V <sub>SD</sub>	V <sub>GS</sub> =0V, I <sub>S</sub> =16A	-	-	1.4	V
Reverse recovery time	t <sub>rr</sub>	I <sub>S</sub> =16A, V <sub>GS</sub> =0V dI <sub>F</sub> /dt=100A/us	-	208	-	ns
Reverse recovery charge	Q <sub>rr</sub>		-	1.63	-	μC

Note ;

- ① Repetitive rating : Pulse width limited by maximum junction temperature
- ② L=3.0mH, I<sub>AS</sub>=16A, V<sub>DD</sub>=50V, R<sub>G</sub>=25Ω, Starting T<sub>J</sub>=25 °C
- ③ Pulse Test : Pulse width≤300us, Duty cycle≤2%
- ④ Essentially independent of operating temperature